

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/604,241 | Applicant(s)/Patent Under Reexamination CUPPLES ET AL. | |
| | Examiner David Buttner | Art Unit 1712 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| | A | US-6,787,626 | 09-2004 | Dewanjee, Pijush K. | 528/64 |
| | B | US-2003/0203771 | 10-2003 | Rosenberg et al. | 473/371 |
| | C | US-2003/0064826 | 04-2003 | Voorheis et al. | 473/367 |
| | D | US-6,486,261 | 11-2002 | Wu et al. | 525/332.6 |
| | E | US-6,309,313 | 10-2001 | Peter, Thomas H. | 473/378 |
| | F | US-3,989,568 | 11-1976 | Isaac, Edward J. | 156/182 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.